

Notice of References Cited

Application/Control No.

10/590,002

Applicant(s)/Patent Under
Reexamination
DEUTSCH ET AL.

Examiner

MYRON WYCHE

Art Unit

2617

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2005/0075093	04-2005	Lei et al.	455/412.1
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NON-PATENT DOCUMENTS

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